

ID	R _{DS} (ON)(Typ)	VDSS
180A	2.2mΩ	30V
• 100% a	: vitching speed avalanche tested red dv/dt capability	

Ordering Information

Part Number	Package	Marking	Packing	Qty.
RS30N180T	T0-220	RS30N180T	Tube	50 PCS

Absolute Maximun Ratings Tc= 25°C unless otherwise specified

Symbol	Parameter	RS30N180T	Units
VDSS	Drain-to-Source Voltage	30	V
ID	Continuous Drain Current TC=25°C	180	
ID	Continuous Drain Current TC=100°C	114	А
IDM	Pulsed Drain Current	720	
PD	Power Dissipation	88	W
VGS	Gate- to- Source Voltage	±20	V
EAS	Single Pulse Avalanche Engergy L = 0.5mH,VDD = 15V, RG = 25Ω, Tj = 25℃	305	mJ
	Maximum Temperature for Soldering		
TL TPKG	Leads at 0.063in(1.6mm)from Case for 10 seconds Package Body for 10 seconds	300 260	°C
TJ and TSTG	Operating Junction and Storage Temperature Range	-55 to 150	

* Drain Current Limited by Maximum Junction Temperature

Caution: Stresses greater than those listed in the "Absolute Maximum Ratings" Table may cause permanent damage to the device.



Thermal Resistance

Symbol	Parameter	RS30N180T	Units	Test Conditions
RθJC	Junction-to-Case	2.1	°C/W	Drain lead soldered to water cooled heatsink, PD adjusted for a peak junction temperature of + 1 5 0 $^\circ\!\mathrm{C}$
RθJA	Junction-to- Ambient	35		1 cubic foot chamber,free air.

OFF Characteristics TJ= 25° C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
BVDSS	Drain- to- source Breakdown	30			V	VGS=0V
BVD33	Voltage				V	ID=250μA
IDSS	Drain- to- Source Leakage			1	μA	VDS=30V
1035	Current			1		VGS=0V
	Gate- to- Source Forward			100	- nA	VGS=20V
	Leakage			100		VDS=0V
IGSS	Gate- to- Source Reverse			100		VGS=-20V
	Leakage			100		VDS=0V

ON Characteristics TJ=25°C unless otherwise specified

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
RDS(on)	Static Drain- to- Source On-		2.2	2.6	mΩ	VGS=10V,ID=30A
	Resistance		3.3	4.3	mΩ	VGS=4.5V ID=20A
VGS(TH)	Gate Threshold Voltage	1.3	1.9	2.5	V	VGS=VDS ID=250μA

Resistive Switching Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
td(ON)	Turn- on Delay Time		16			VDS=15V ID=30A RG=3Ω VGS=10V
trise	Rise Time		30		nS	
td(OFF)	Turn- OFF Delay Time		52			
tfall	Fall Time		20			



Dynamic Characteristics Essentially independent of operating temperature

Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions
Ciss	Input Capacitance		5060			VGS= 0V
Coss	Output Capacitance		570		pF	VDS=15V
Crss	Reverse Transfer Capacitance		470			f=1.0MHz
Qg	Total Gate Charge		75			VDS= 15V
Qgs	Gate- to- Source Charge		9		nC	ID=20A
Qgd	Gate-to-Drain(" Miller") Charge		18			VGS=10V

Source- Drain Diode Characteristics

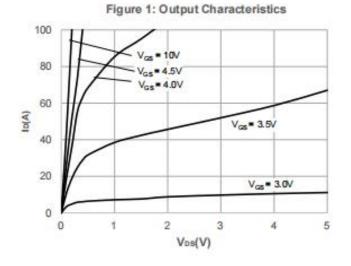
Symbol	Parameter	Min.	Тур.	Max.	Units	Test Conditions	
IS	Continuous Source Current			180	Α	Integral pn- diode	
ISM	Maximum Pulsed Current			720	Α	in MOSFET	
VSD	Diode Forward Voltage			1.2	V	IS=30A,VGS=0V	
trr	Reverse Recovery Time		24		nS	VGS=0V	
Qrr	Reverse Recovery Charge		14		nC	IS=30A di/dt=100A/μs	

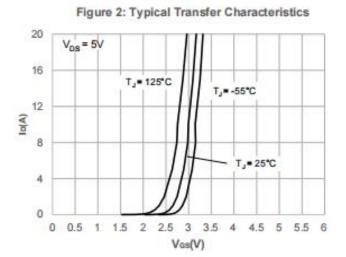
Notes:

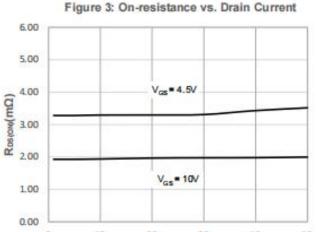
- * 1. Repetitive rating, pulse width limited by maximum junction temperature.
- * 2. Pulse Test: Pulse width \leq 300µs, Duty Cycle \leq 1%

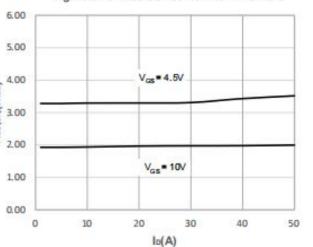


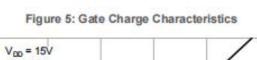
Typical Feature Curve











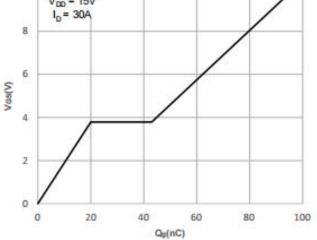
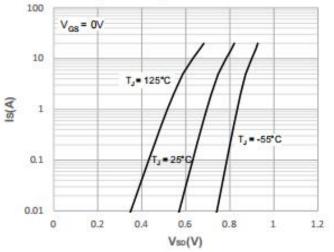
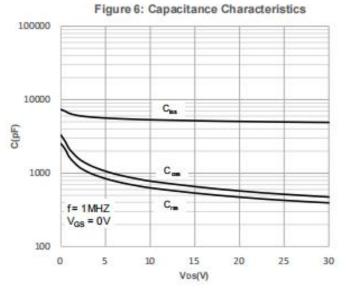


Figure 4: Body Diode Characteristics



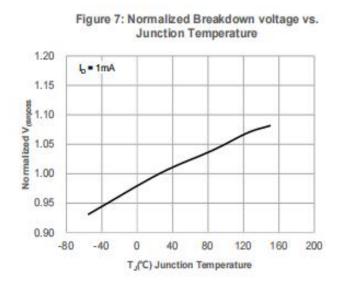


REV:J-B02-05-2024 www.reasunos.com

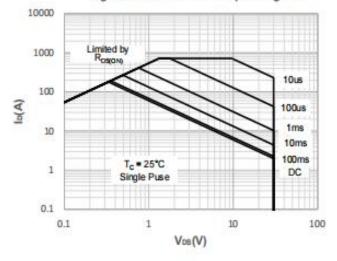
10

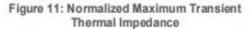
Copyright Reasunos

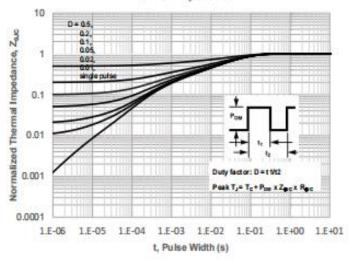












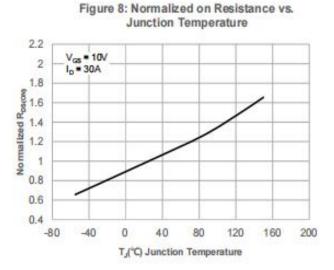


Figure 10: Maximum Continuous Drian Current vs. Case Temperature

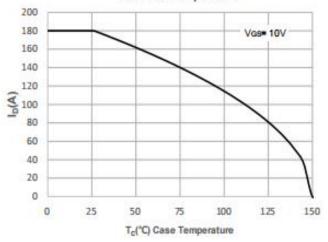
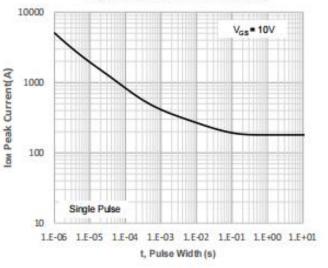


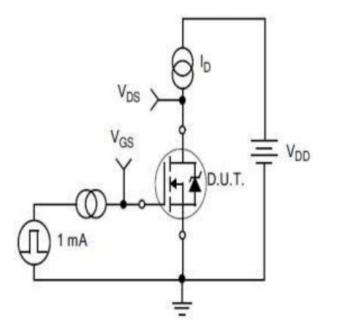
Figure 12: Peak Current Capacity



REV:J-B02-05-2024 www.reasunos.com



Test ircuits and Waveforms



VGS(TH)

VDS

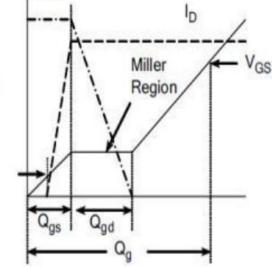


Figure A. Gate Charge Test Circuit

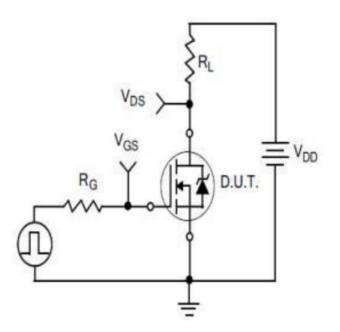


Figure C. Resistive Switching Test Circuit

Figure B. Gate Charge Waveform

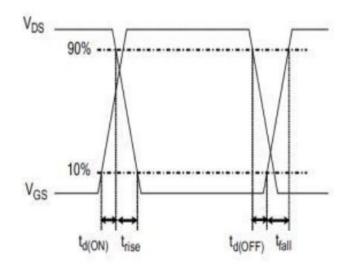
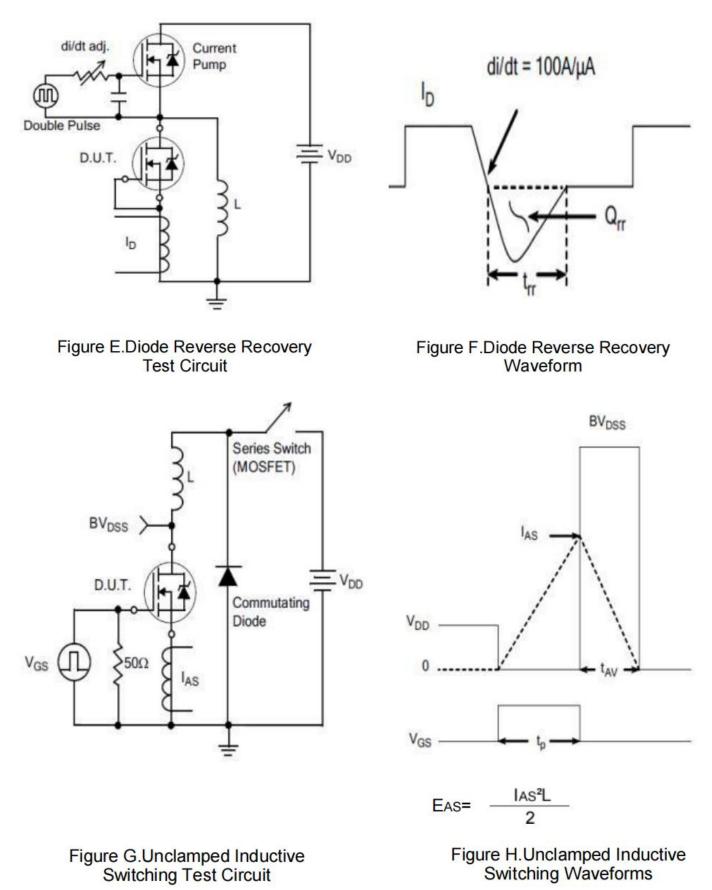


Figure D. Resistive Switching Waveforms

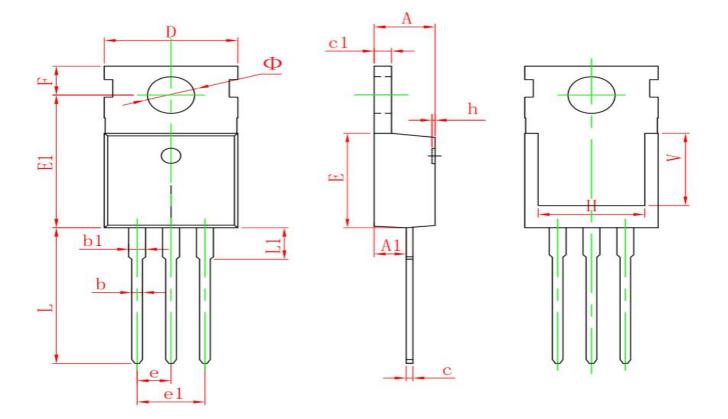


Test ircuits and Waveforms





Package outline drawing(TO-220 Unit: mm)



Symbol	Dimensions	In Millimeters	Dimension	s in inches	
Symbol	Min.	Max.	Min.	Max.	
A	4.400	4.600	0.173	0.181	
A1	2.250	2.550	0.089	0.100	
b	0.710	0.910	0.028	0.036	
b1	1.170	1.370	0.046	0.054	
С	0.330	0.650	0.013	0.026	
c1	1.200	1.400	0.047	0.055	
D	9.910	10.250	0.390	0.404	
E	8.950	9.750	0.352	0.384	
E1	12.650	13.050	0.498	0.514	
е	2.540	TYP.	0.100) TYP.	
e1	4.980	5.180	0.196	0.204	
F	2.650	2.950	0.104	0.116	
Н	7.900	8.100	0.311	0.319	
h	0.000	0.300	0.000	0.012	
L	12.900	13.400	0.508	0.528	
L1	2.850	3.250	0.112	0.128	
V	6.900	REF.	0.276 REF.		
Φ	3.400	3.800	0.134	0.150	



Disclaimers:

Reasunos Semiconductor Technology Co.Ltd (Reasunos) reserves the right to make changes without notice in order to improve reliability,function or design and to discontinue any product or service without notice .Customers should obtain the latest relevant information before orders and should verify that such information in current and complete.All products are sold subject to Reasunos's terms and conditions supplied at the time of orderacknowledgement.

Reasunos Semiconductor Technology Co.Ltd warrants performance of its hardware products to the speciffications at the time of sale.Testing,reliability and quality control are used to the extene Reasunos deems necessary to support this warrantee. Except where agreed upon by contr- actual agreement,testing of all parameters of each product is not necessarily performed.

Reasunos Semiconductor Technology Co.Ltd does not assume any liability arising from the use of any product or circuit designs described herein.Customers are responsible for their products and applications using Reasunos's components.To minimize risk,customers must provide adequate design and operating safeguards.

Reasunos Semiconductor Technology Co.Ltd does not warrant or convey any license eith- er expressed or implied under its patent rights, nor the rights of others. Reproduction of inform- ation in Reasunos's data sheeets or data books is permissible only if reproduction is without modification oralteration. Reproduction of this information with any alteration is an unfair and deceptive business practice. Reasunos Semiconductor Technology Co.Ltd is not responsi- ble or liable for such altered documentation.

Resale of Reasunos's products with statements different from or beyond the parameters stated by Reasunos Semiconductor Technology Co.Ltd for that product or service voids all exp- ress or implied warrantees for the associated Reasunos's product or service and is unfair and deceptive business practice. Reasunos Semiconductor Technology Co.Ltd is not responsi- ble or liable for such statements.

Life Support Policy:

Reasunos Semiconductor Technology Co.Ltd's Products are not authorized for use as cri- tical components in life support devices or systems without the expressed written approval of Reasunos Semiconductor Technology Co.Ltd.

As used herein:

1. Life support devices or systems are devices or systems which: a.are intended for surgical implant into the human body, b.support or sustain life,

c.whose failuer to when properly used in accordance with instructions for used provided in the laeling,can be reasonably expected to result in significant injury to the user.

2.A critical component is any component of a life support device or system whose failure to system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.